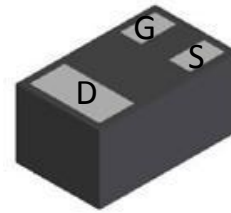
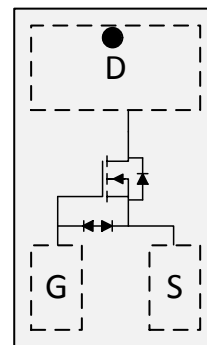


WNM2072
Single N-Channel, 20V, 0.71A, Power MOSFET
[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

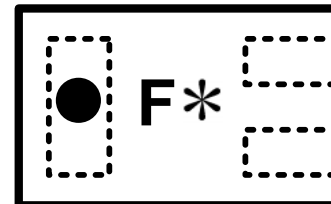
V_{DS} (V)	Typical $R_{DS(on)}$ ()
20	0.220@ $V_{GS}=4.5V$
	0.260@ $V_{GS}=2.5V$
	0.315@ $V_{GS}=1.8V$
ESD Protected	


DFN1006-3L
Descriptions

The WNM2072 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM2072 is Pb-free.


Pin configuration (Top view)
Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package DFN1006-3L



F = Device Code
* = Month (A~Z)

Marking
Applications

- Small Signal Switching
- Small Moto Driver

Order information

Device	Package	Shipping
WNM2072-3/TR	DFN1006-3L	10K/Tape&Reel

Absolute Maximum ratings

Parameter		Symbol	10 S	Steady State	Unit
Drain-Source Voltage		V_{DS}	20		V
Gate-Source Voltage		V_{GS}	± 5		
Continuous Drain Current ^{a d}	$T_A=25^\circ\text{C}$	I_D	0.71	0.66	A
	$T_A=70^\circ\text{C}$		0.57	0.52	
Maximum Power Dissipation ^{a d}	$T_A=25^\circ\text{C}$	P_D	0.32	0.27	W
	$T_A=70^\circ\text{C}$		0.20	0.17	
Continuous Drain Current ^{b d}	$T_A=25^\circ\text{C}$	I_D	0.67	0.62	A
	$T_A=70^\circ\text{C}$		0.54	0.50	
Maximum Power Dissipation ^{b d}	$T_A=25^\circ\text{C}$	P_D	0.28	0.24	W
	$T_A=70^\circ\text{C}$		0.18	0.15	
Pulsed Drain Current ^c		I_{DM}	1.4		A
Operating Junction Temperature		T_J	150		$^\circ\text{C}$
Lead Temperature		T_L	260		$^\circ\text{C}$
Storage Temperature Range		T_{stg}	-55 to 150		$^\circ\text{C}$

Thermal resistance ratings

Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance ^a	t 10 s	R_{JA}	350	390	$^\circ\text{C/W}$
	Steady State		395	455	
Junction-to-Ambient Thermal Resistance ^b	t 10 s	R_{JA}	397	435	
	Steady State		445	505	
Junction-to-Case Thermal Resistance		R_{JC}	240	280	

a Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper

b Surface mounted on FR4 board using minimum pad size, 1oz copper

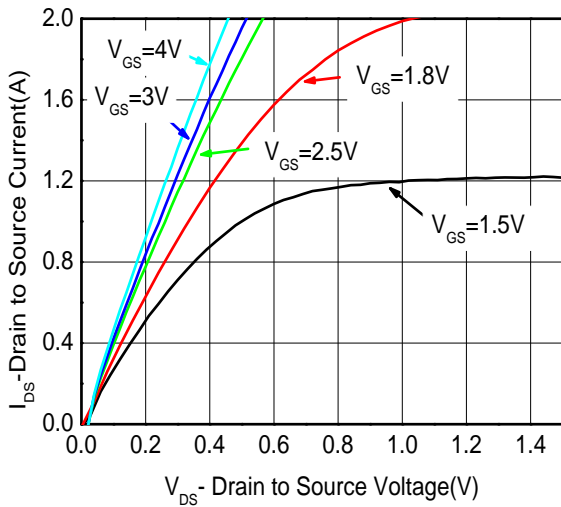
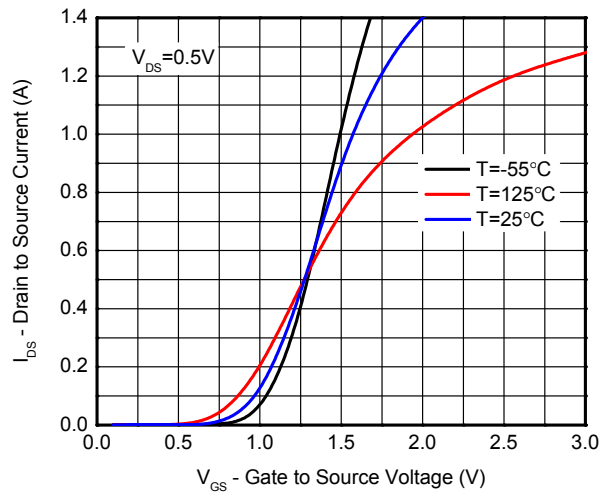
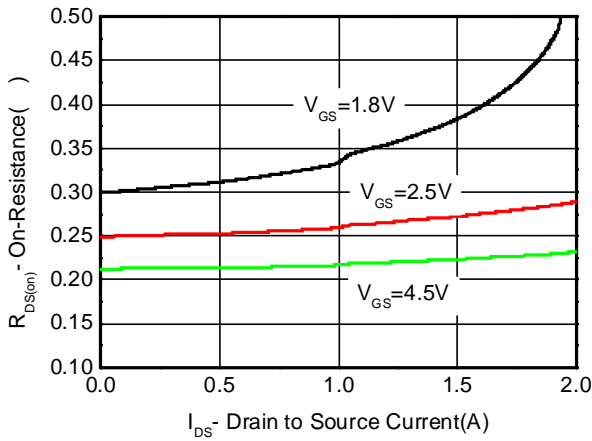
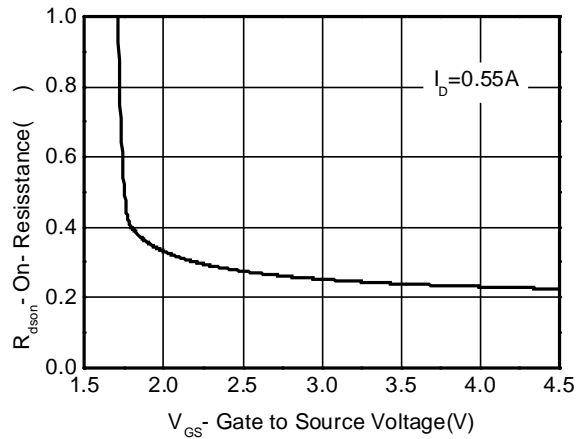
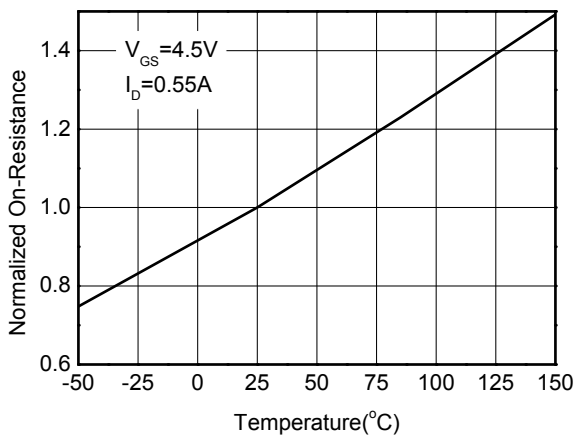
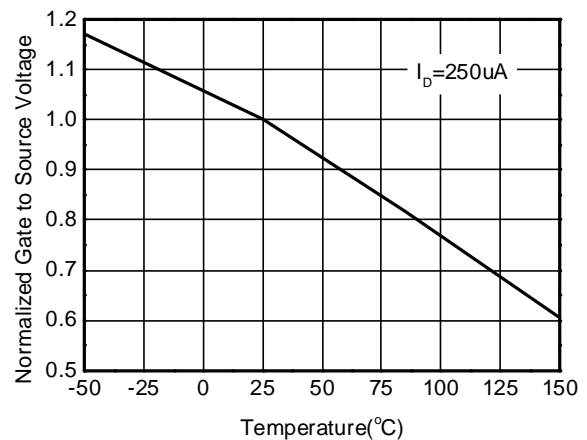
c Pulse width < 380 μs , Single pulse

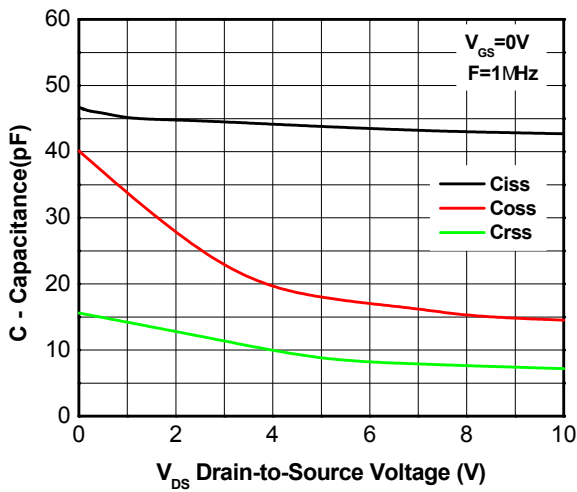
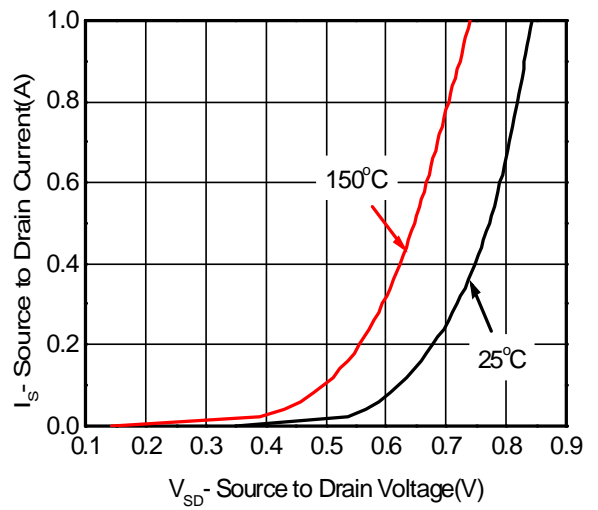
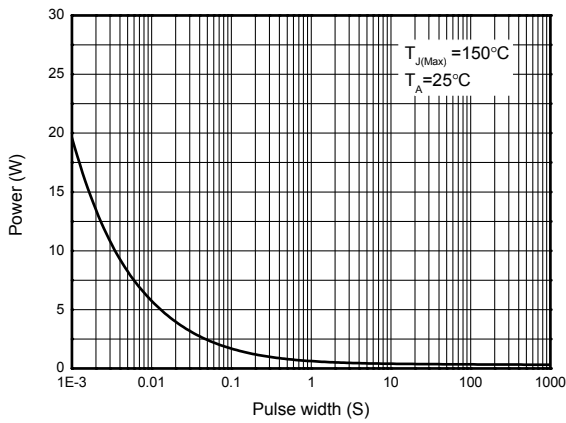
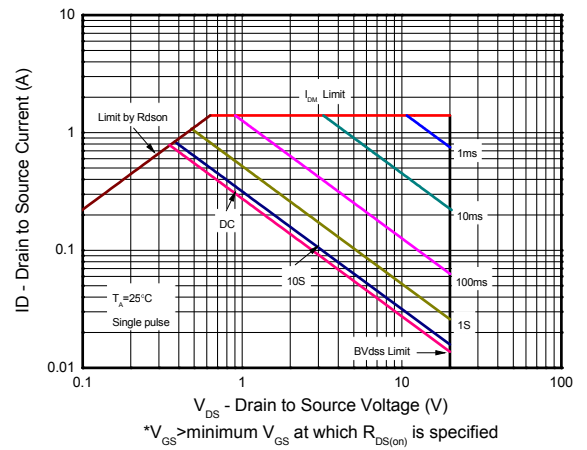
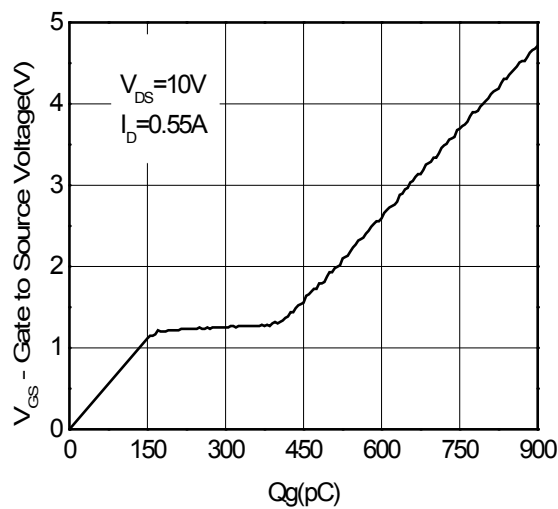
d Maximum junction temperature $T_J=150^\circ\text{C}$.

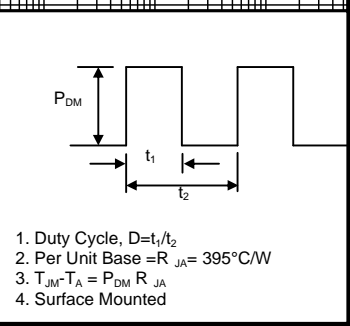
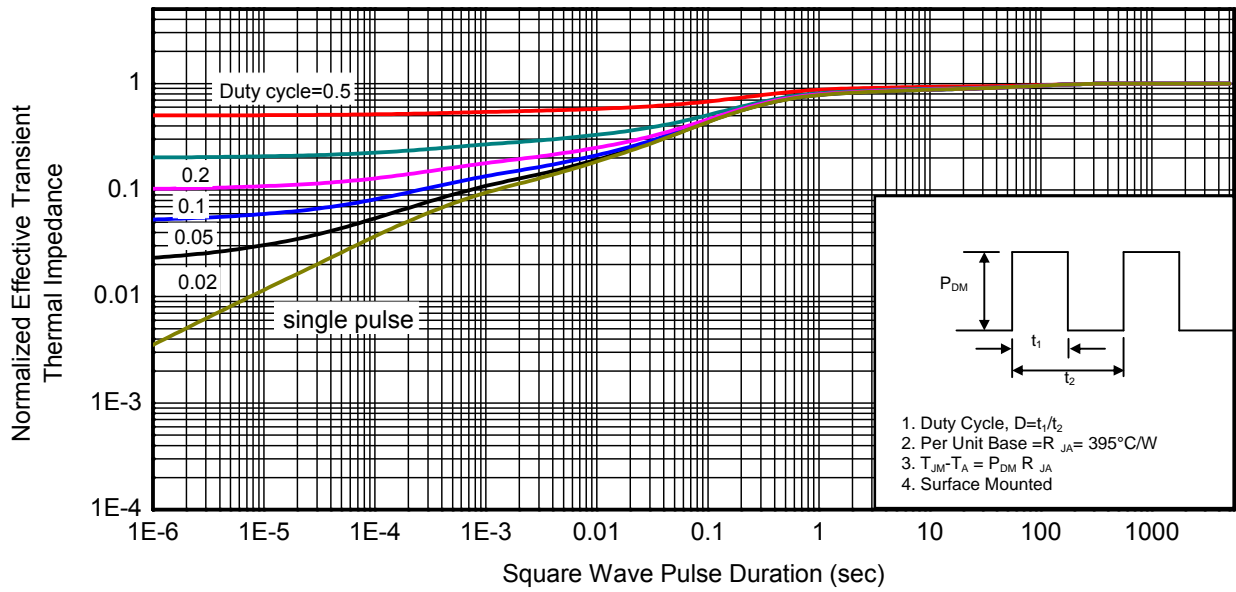
e Pulse test: Pulse width < 380 us duty cycle < 2%.

Electronics Characteristics (Ta=25°C, unless otherwise noted)

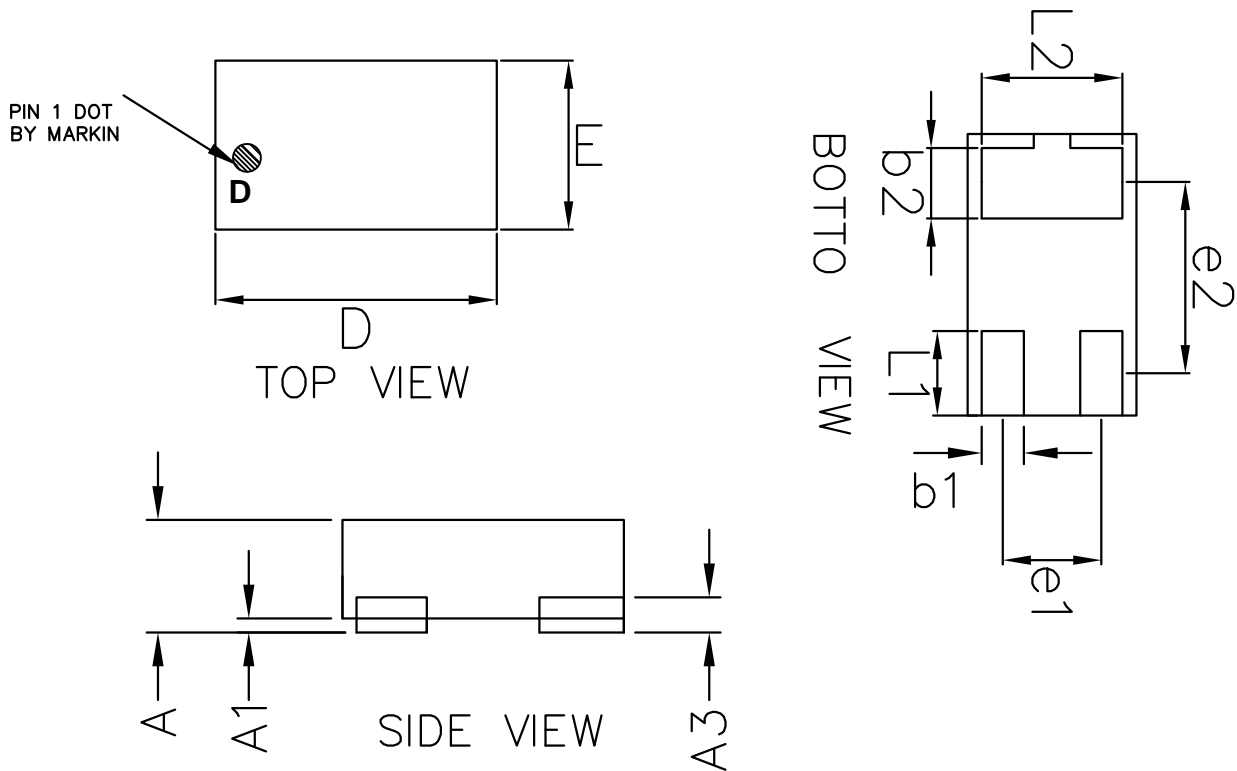
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = 250\mu\text{A}$	20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16\text{ V}, V_{GS} = 0\text{ V}$			1	μA
Gate-to-source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 5\text{ V}$			± 5	μA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	0.45	0.58	0.85	V
Drain-to-source On-resistance ^e	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}, I_D = 0.55\text{ A}$		220	420	m
		$V_{GS} = 2.5\text{ V}, I_D = 0.45\text{ A}$		260	500	
		$V_{GS} = 1.8\text{ V}, I_D = 0.35\text{ A}$		315	600	
Forward Transconductance	g_{FS}	$V_{DS} = 5\text{ V}, I_D = 0.55\text{ A}$		2.0		S
CHARGES, CAPACITANCES AND GATE RESISTANCE						
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}, f = 1\text{ MHz}, V_{DS} = 10\text{ V}$		50.6		pF
Output Capacitance	C_{OSS}			13.2		
Reverse Transfer Capacitance	C_{RSS}			8.3		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 10\text{ V}, I_D = 0.55\text{ A}$		0.87		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.06		
Gate-to-Source Charge	Q_{GS}			0.15		
Gate-to-Drain Charge	Q_{GD}			0.27		
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$t_d(ON)$	$V_{GS} = 4.5\text{ V}, V_{DS} = 10\text{ V}, I_D = 0.55\text{ A}, R_G = 6$		16		ns
Rise Time	t_r			11.6		
Turn-Off Delay Time	$t_d(OFF)$			36		
Fall Time	t_f			11		
BODY DIODE CHARACTERISTICS						
Forward Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 0.35\text{ A}$	0.5	0.7	1.1	V

Typical Characteristics (Ta=25°C, unless otherwise noted)

Output characteristics

Transfer characteristics

On-Resistance vs. Drain current

On-Resistance vs. Gate-to-Source voltage

On-Resistance vs. Junction temperature

Threshold voltage vs. Temperature

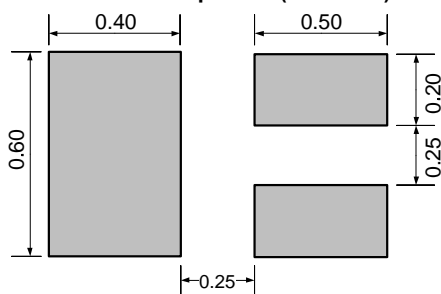

Capacitance

Body diode forward voltage

Single pulse power

Safe operating power




Transient thermal response (Junction-to-Ambient)

Package outline dimensions
DFN1006-3L


COMMON DIMENSIONS(MM)			
PKG.	X1: EXTREME THIN		
REF.	MIN.	NOM.	MAX
A	>0.40	—	0.50
A1	0.00	—	0.05
A3	0.125 REF.		
D	0.95	1.00	1.05
E	0.55	0.60	0.65
b1	0.10	0.15	0.20
b2	0.20	0.25	0.30
L1	0.20	0.30	0.40
L2	0.45	0.50	0.55
e1	0.35 BSC		
e2	0.675 BSC		

Recommend land pattern (Unit: mm)


Note: This land pattern is for your reference only. Actual pad layouts may vary depending on application.